



Process for Patterning Indium for Bump Bonding

Goddard Space Flight Center, Greenbelt, Maryland

An innovation was created for the Cosmology Large Angular Scale Surveyor for integration of low-temperature detector chips with a silicon backshort and a silicon photonic choke through flip-chip bonding. Indium bumps are typically patterned using liftoff processes, which require thick resist. In some applications, it is necessary to locate the bumps close to high-aspect-ratio structures such as wafer through-holes. In those cases, liftoff processes are challenging, and require complicated and time-consuming spray coating technology if the high-aspect-ratio structures are

delineated prior to the indium bump process. Alternatively, processing the indium bumps first is limited by compatibility of the indium with subsequent processing. The present invention allows for locating bumps arbitrarily close to multiple-level high-aspect-ratio structures, and for indium bumps to be formed without liftoff resist.

The process uses the poor step coverage of indium deposited on a silicon wafer that has been previously etched to delineate the location of the indium bumps. The silicon pattern can be processed through standard lithogra-

phy prior to adding the high-aspect-ratio structures. Typically, high-aspect-ratio structures require a thick resist layer so this layer can easily cover the silicon topography. For multiple levels of topography, the silicon can be easily conformally coated through standard processes. A blanket layer of indium is then deposited onto the full wafer; bump bonding only occurs at the high points of the topography.

This work was done by Kevin Denis of Goddard Space Flight Center. Further information is contained in a TSP (see page 1). GSC-16386-1

Archway for Radiation and Micrometeorite Occurrence Resistance

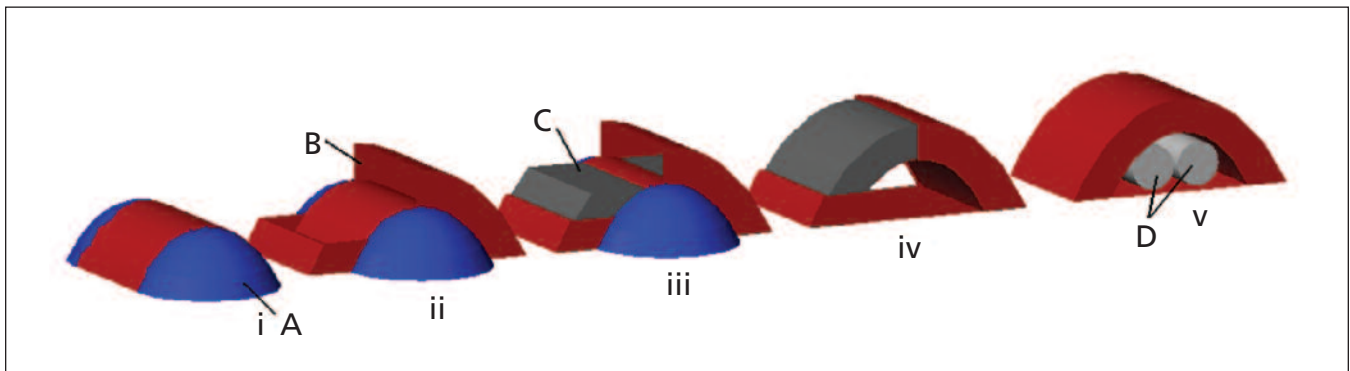
This technology can be used where there is a need to rapidly deploy large, rugged structures including military, emergency services and disaster relief, and camping.

NASA's Jet Propulsion Laboratory, Pasadena, California

The environmental conditions of the Moon require mitigation if a long-term human presence is to be achieved for extended periods of time. Radiation, micrometeoroid impacts, high-velocity debris, and thermal cycling represent threats to crew, equipment, and facilities. For decades, local regolith has been suggested as a candidate material to use in the construction of protective barriers. A thickness of roughly 3 m is

sufficient protection from both direct and secondary radiation from cosmic rays and solar protons; this thickness is sufficient to reduce radiation exposure even during solar flares. NASA has previously identified a need for innovations that will support lunar habitats using lightweight structures because the reduction of structural mass translates directly into additional up and down mass capability that would facilitate addi-

tional logistics capacity and increased science return for all mission phases. The development of non-pressurized primary structures that have synergy with the development of pressurized structures is also of interest. The use of indigenous or in situ materials is also a well-known and active area of research that could drastically improve the practicality of human exploration beyond low-Earth orbit.



Views of ARMOR Construction. The temporary inflatable (A) deploys (i). Then the jacket (B) is deployed (ii). Regolith (C) is then poured into the jacket and initially supported by the inflatable (iii). When the jacket is filled, the regolith inside the arch of the jacket is self-supporting, and the inflatable is no longer necessary (iv). Habitat modules and equipment (D) can be moved into the ARMOR (v). The jacket is shown in cutaway in steps (ii), (iii), and (iv) to illustrate regolith filling.